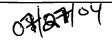
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## **ELECTRONIC INFORMATION DISCLOSURE STATEMENT**

## Electronic Version v18

Stylesheet Version v18.0



Title of Invention

CIRCUIT AND METHOD FOR MONITORING DEFECTS

**Application Number:** 

10/710,640

Confirmation Number:

First Named Applicant:

Greg Bazan

Attorney Docket Number:

BUR920040044US1

Art Unit:

2829

Examiner:

TANG

Search string:

(6556949 or 6513151 or 6473665 or 6470485 or 6470229 or 6389323 or 6341241

or 6210983 or 6185707 or 6017771 or 5999003 or 5675589 or 5550843 or T994007

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Note: Applicant is not required to submit a paper copy of cited US Patent Documents

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## **Signature**

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